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FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

Sheet 1 of 1 ATTORNEY DOCKET NO. 10/806,320 1293.1278C3

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

FIRST NAMED INVENTOR Yong-jin Ahn et al. GROUP ART UNIT FILING DATE 2655 March 23, 2004

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DOCUMENT NO. 6,104,685	DATE 08/2000	NAME Hideki, et al.	class	SUB- CLASS	FILING DATE
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FOREIGN PATENT DOCUMENTS

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		DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO	ABSTRACT
Le	AG	1186297	07/1998	China	X	<u> </u>
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	AJ					<del>                                     </del>
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OTHER REFERE	NCES (Including Author, Title, Date, Pertinent Pages, Etc.)	TRANSLATION YES NO
Le AM	Copy of Chinese Office Action issued February 18, 2005	х

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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FORM PTO-1449

PATENT AND TRADEMARK OFFICE

| Sheet 1 of 1 | APPLICATION NO. | 1293.1278C3 | 10/806,320 | EIRST NAMED INVENTOR

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

FIRST NAMED INVENTOR	
Yong-jin Ahn et al.	
FILING DATE	GROUP ART UNIT
March 23, 2004	2655

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*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
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Sheet 1 of 1 ATTORNEY DOCKET NO. U.S. DEPARTMENT OF COMMERCE **FORM PTO-1449** PATENT AND TRADEMARK OFFICE 1293.1278C3 10/806,320 FIRST NAMED INVENTOR LIST OF REFERENCES CITED BY APPLICANT Yong-jin Ahn et al. FILING DATE GROUP ART UNIT (Use several sheets if necessary) March 23, 2004 2655 **U.S. PATENT DOCUMENTS** DOCUMENT \*EXAMINER SUB-**FILING** INITIAL NO. DATE NAME **CLASS** CLASS DATE AA LC 369 5,291,470 03/1994 26-90 Nishiuchi et al. 120 AB AC AD AE AF FOREIGN PATENT DOCUMENTS DOCUMENT NO. **ABSTRACT** DATE **COUNTRY TRANSLATION** YES NO AG AH ΑI AJ AK AL OTHER REFERENCES (including Author, Title, Date, Perlinent Pages, Etc.) TRANSI ATION YES NO MA EXAMINER DATE CONSIDERED

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citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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LIST OF	REF	ERENCES C	ITED BY	APPLICANT	FIRST NAMED INVENTOR					
	1761	LINEINOLO	וובטטו	ALL LIOAN	Yong-jin Ahn et al.  FILING DATE   GROUP ART UNIT					<b>,</b>
	(Us	se several sheets	if necessa	ry)	March 23, 2004			GROOPA	KI UN	'
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*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME		CLAS	CLASS CLA			LING ATE
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



## LIST OF COPENDING APPLICATIONS

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T	ATTORNEY DOCKET NO.	APPLICATION NO.
L	1293.1278C3	10/806,320
ſ	FIRST NAMED INVENTOR	
L	Yong-jin Ahn et al.	
Γ	FILING DATE	GROUP ART UNIT
ı	March 23, 2004	

The following, prior-filed, copending U.S. patent application(s) is/are listed in accordance with the duty of disclosure provisions of 37 CFR § 1.56, so that the Examiner may consider same should he deem any thereof to be material to examination of the subject application. Pursuant to 37 CFR 1.98(a)(2)(iii), a copy of the identified copending application(s) is provided.

It is requested that the Examiner acknowledge his consideration of application(s) below-listed by initialling same in the space provided adjacent each such application and that the Examiner sign and date this form at the bottom thereof to confirm such consideration having been given.

This submission in no way represents an admission that any of the information listed herein constitutes prior art with respect to the subject application and unless and until such prior art status is established, this submission is not a request that the information presented herein be printed on the face of any patent issuing from the subject application in which this information is being filed.

**U.S. PATENT APPLICATION DOCUMENTS** 

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*EXAMINER INITIAL		U.S. SERIAL NO.	FILING DATE	NAME	ASSIGNEE
LC	1	10/256,244	9/27/02	Yong-jin AHN et al.	Samsung Electronics Co., Ltd.
LC	2	10/806,106	3/23/04	Yong-jin AHN et al.	Samsung Electronics Co., Ltd.
ic	3	10/806,107	3/23/04	Yong-jin AHN et al.	Samsung Electronics Co., Ltd.
W	4	10/806,318	3/23/04	Yong-jin AHN et al.	Samsung Electronics Co., Ltd.
K	5	10/806,319	3/23/04	Yong-jin AHN et al.	Samsung Electronics Co., Ltd.
il	6	10/806,215	3/23/04	Yong-jin AHN et al.	Samsung Electronics Co., Ltd.
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*EXAMINER: Initial if reference considered, whether or no citation if not in conformance and not considered. Include co	ot citation is in conformance with MPEP 609; Draw line through opy of this form with next communication to applicant.		
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